



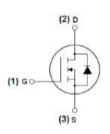
## MJ N-Channel Enhancement Mode Power MOSFET

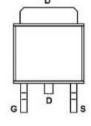
### Description

The MJ40H12K uses advanced trench technology and design to provide excellent  $R_{DS(ON)}$  with low gate charge. It can be used in a wide variety of applications.

#### General Features

- $ightharpoonup V_{DS} = 40V, I_D = 120A$   $ightharpoonup R_{DS(ON)} < 4.0 mΩ @ V_{GS} = 10V$   $ightharpoonup R_{DS(ON)} < 7.0 mΩ @ V_{GS} = 4.5V$
- ◆ High density cell design for ultra low Rdson
- ◆ Fully characterized avalanche voltage and current
- ◆ Good stability and uniformity with high EAS
- ◆ Excellent package for good heat dissipation
- ◆ Special process technology for high ESD capability



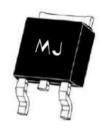


Application

Load switching

Hard switched and high frequency circuits

Uninterruptible power supply



Schematic diagram

Marking and pin assignment

TO-252-2L top view

### 100% UIS TESTED! 100% ΔVds TESTED!

### Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
MJ40H12K	MJ40H12K	TO-252-2L	-	-	

### Absolute Maximum Ratings (Tc =25 °Cunless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	VDS	40	V
Gate-Source Voltage	Vgs	±20	V
Drain Current-Continuous	ΙD	120	А
Drain Current-Continuous(Tc =100℃)	<b>I</b> D(100℃)	85	Α
Pulsed Drain Current	Ідм	330	Α
Maximum Power Dissipation	PD	120	W
Derating factor		0.8	W/°C
Single pulse avalanche energy (Note 5)	Eas	1080	mJ
Operating Junction and Storage Temperature Range	Тл,Тѕтс	-55 To 175	°C

#### Thermal Characteristic

Thermal Resistance, Junction-to-Case (Note 2) ReJC 1.25	°C/W
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## Electrical Characteristics (Tc =25°Cunless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics	'					
Drain-Source Breakdown Voltage	BVpss	V <sub>GS</sub> =0V I <sub>D</sub> =250μA	40	45	-	V
Zero Gate Voltage Drain Current	Ipss	V <sub>DS</sub> =40V,V <sub>GS</sub> =0V	-	-	1	μΑ
Gate-Body Leakage Current	lgss	V <sub>DS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	VGS(th)	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250µA	1.2	1.8	2.5	V
Dunin Course On State Registeres	D	Vgs=10V, Ip=20A	-	3.6	4.0	mΩ
Drain-Source On-State Resistance	Rds(on)	V <sub>GS</sub> =4.5V, I <sub>D</sub> =10A	-	5.8	7.0	mΩ
Forward Transconductance	gFS	V <sub>DS</sub> =10V,I <sub>D</sub> =20A	26	-	-	S
Dynamic Characteristics (Note 4)						
nput Capacitance	Clss		-	5400	-	PF
Output Capacitance	Coss	V <sub>DS</sub> =20V,V <sub>GS</sub> =0V F=1.0MHz	-	970	-	PF
Reverse Transfer Capacitance	Crss		-	380	-	PF
Switching Characteristics (Note 4)	'					
Turn-on Delay Time	t <sub>d(on)</sub>		-	15	-	nS
Turn-on Rise Time	tr	V <sub>DD</sub> =20V,I <sub>D</sub> =2A,R <sub>L</sub> =1Ω	-	18	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>	V <sub>GS</sub> =10V,R <sub>G</sub> =3Ω	-	52	-	nS
Turn-Off Fall Time	tr		-	23	-	nS
Total Gate Charge	Qg		-	75	-	nC
Gate-Source Charge	Qgs	V <sub>DS</sub> =20V,I <sub>D</sub> =20A V <sub>GS</sub> =10V	-	10.5	-	nC
Gate-Drain Charge	Qgd	-	-	17	_	nC
Drain-Source Diode Characteristics				<u> </u>		<u> </u>
Diode Forward Voltage (Note 3)	VsD	V <sub>GS</sub> =0V,I <sub>S</sub> =40A	-	-	1.2	V
Diode Forward Current (Note 2)	Is		-	_	120	Α
Reverse Recovery Time	t <sub>rr</sub>	T0500 I- 404	-	42	_	nS
Reverse Recovery Charge	Qrr	TJ=25°C, IF=40A di/dt=100A/µs (Note 3)	_	45	_	nC
Forward Turn-On Time	ton	Intrinsic turn-on time is ne	aliaible/te	urn on ic d	emineted b	

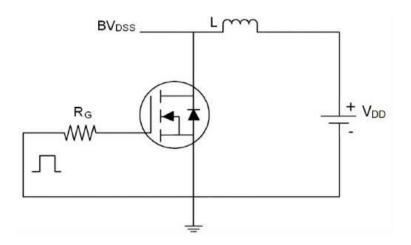
### Notes:

- $\textcircled{\scriptsize 1} \ \, \mathsf{Repetitive} \ \, \mathsf{Rating:} \ \, \mathsf{Pulse} \ \, \mathsf{width} \, \, \mathsf{limited} \, \, \mathsf{by} \, \, \mathsf{maximum} \, \mathsf{junction} \, \, \mathsf{temperature}. \\$
- ② Surface Mounted on FR4 Board, t ≤ 10 sec.
- ③ Pulse Test; Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- ④ Guaranteed by design, not subject to production
- ⑤ EAS condition: Tj=25°C, V<sub>DD</sub>=20V, V<sub>G</sub>=10V, L=1mH, Rg=25Ω, I<sub>AS</sub>=46.5A

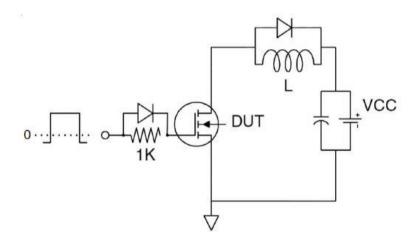




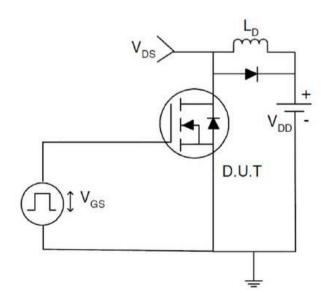
### Test circuit



Eas test Circuit



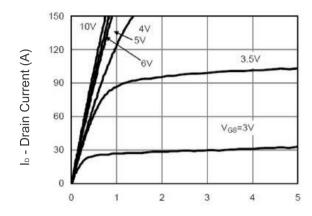
Gate charge test Circuit



Switch Time Test Circuit

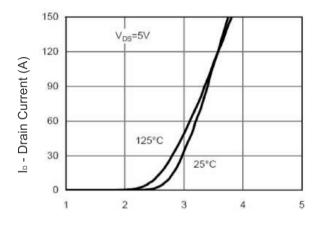


### Typical Electrical and Thermal Characteristics (Curves)



Vds Drain-Source Voltage (V)

Figure 1 Output Characteristics



Vgs Gate-Source Voltage (V) Figure 2 Transfer Characteristics

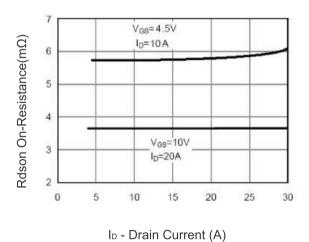
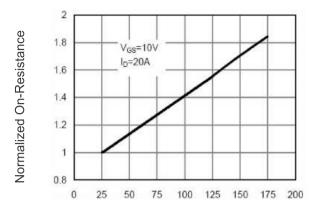
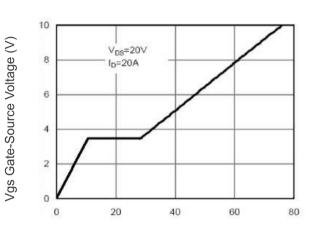


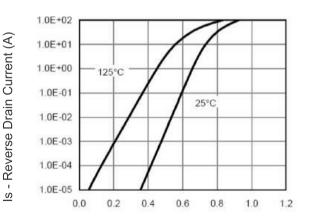
Figure 3 Rdson- Drain Current



T<sub>J</sub> -Junction Temperature(°C) Figure 4 Rdson-Junction Temperature

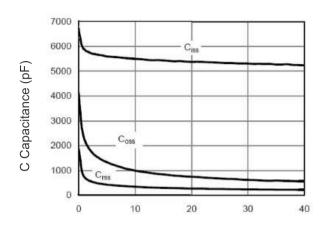


Qg Gate Charge (nC) Figure 5 Gate Charge

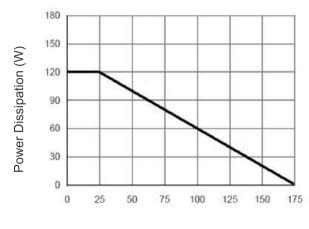


Vsd Source-Drain Voltage (V) Figure 6 Source- Drain Diode Forward

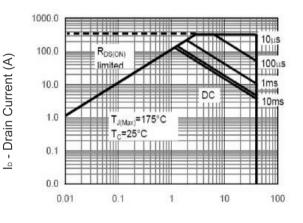




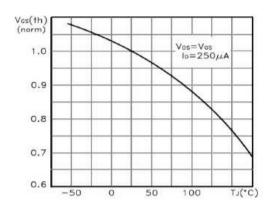
Vds Drain-Source Voltage (V)
Figure 7 Capacitance vs Vds



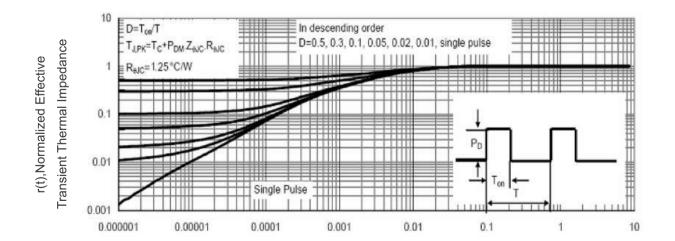
T<sub>J</sub> -Junction Temperature(°C)
Figure 9 Power De-rating



Vds Drain-Source Voltage (V)
Figure 8 Safe Operation Area



T<sub>J</sub> -Junction Temperature(°C)
Figure 10 V<sub>GS(th)</sub> vs Junction Temperature



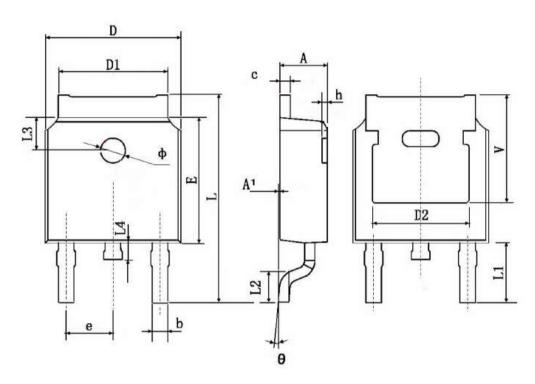
Square Wave Pluse Duration(sec)

Figure 11 Normalized Maximum Transient Thermal Impedance





# TO-252 Package Information



O	Dimensions	In Millimeters	Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
Α	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.660	0.860	0.026	0.034
С	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	4.8	30 TYP.	0.190 TYP.	
E	6.000	6.200	0.236	0.244
е	2.186	2.386	0.086	0.094
L	9.800	10.400	0.386	0.409
L1	2.900 TYP.		0.114 TYP.	
L2	1.400	1.700	0.055	0.067
L3	1.600 TYP.		0.063 TYP.	
L4	0.600	1.000	0.024	0.039
Φ	1.100	1.300	0.043	0.051
θ	0°	8°	0 °	8°
h	0.000	0.300	0.000	0.012
V	5.350	TYP.	0.211 TYP.	





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